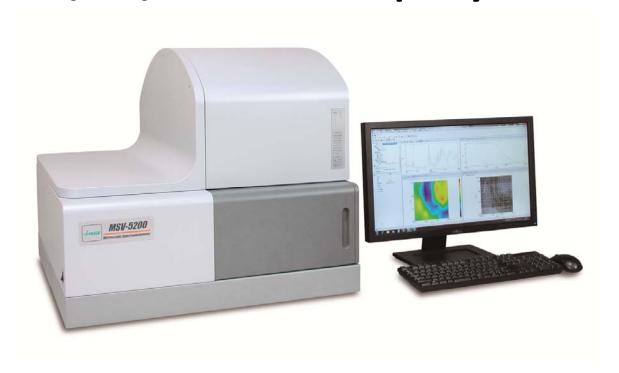


# MSV-5000 Series UV/Vis/NIR Microscope System







# MSV-5100 / MSV-5200 / MSV-5300 UV/Vis/NIR Micro-spectrophotometer

The MSV-5000 series are UV/Vis/NIR microscopic spectrophotometer systems which can measure transmittance or reflectance of micro samples and points in a wide range from UV to NIR.

The MSV-5000 series incorporates a high performance UV-Vis/NIR spectrophotometer that can be applied to micro measurements and extended to materials analysis and many other application areas.



#### **External View**



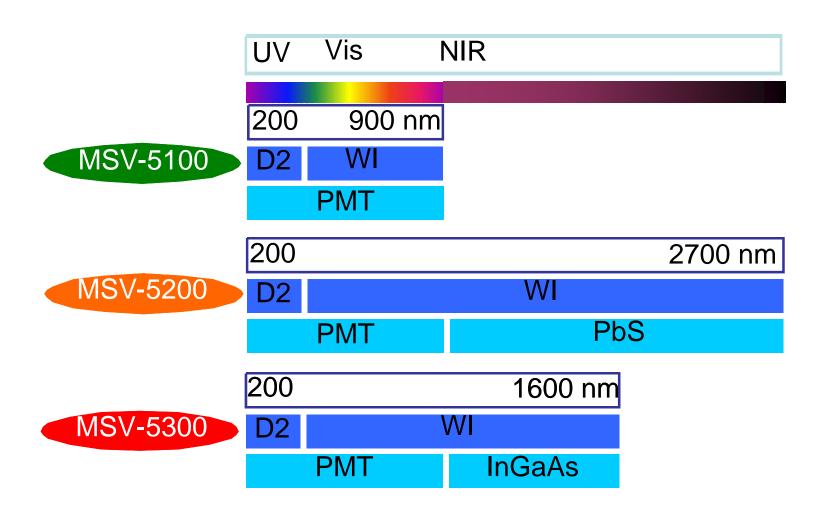
- Light shielding door (front and side, manual)
- Sample illumination
- Optional cassegrain selections
- Optional auto-stage

- Monochromator and microscope in one unit
- New design and color
- No dedicated table required
- USB communication (MSV-5000 and camera)





# MSV Wavelength Ranges





- Continuous spectral measurement in a wide range from UV to NIR, without changes in optical components
- High performance monochromator with high wavelength resolution and accuracy
- Excellent photometric stability using dual-beam optics
- Minimum measurement area of 10 μm
- Sample observation using a CMOS camera
- Polarization measurement function as standard
- Optional auto XYZ stage for Mapping and multi-point measurements
- JASCO Spectra Manager Version 2



### Continuous Spectral Measurement

- Broad band monochromator
  - Automatic switching of light source, grating and detector
- Reflection optics with NO light losses
  - Cassegrain objectives and collection mirrors
  - Reference optical path with reflection optics
    - Double beam measurement for full wavelength range
- Measurement modes
  - Transmittance, reflectance, transmittance/reflectance

## High Performance Monochromator

- Czerny-Turner mount single monochromator
- High wavelength resolution
  - 0.1 nm (Vis)
  - -0.4 nm (NIR)
- High wavelength accuracy
  - $-\pm 0.3$  nm (Vis)
  - $-\pm 1.5$  nm (NIR)



# **Excellent Photometric Stability**

- Reflection optics for both sample and reference beam paths
- Newly mounted attenuator
- Expansion of wavelength range
- Effective utilization of instrument dynamic range



#### Minimum Measurement Area

- Aperture: Selectable by switching
- Size (for 16X Cassegrain):
  - 10, 20, 30, 50, 100, 200 μm (circular apertures)
  - Slit type (adjustable aperture)



# Sample Observation

- CMOS camera
- Optical and digital zoom functions
- Easy observation of microscopic measurement spot
- Binocular and visual polarizer options



#### **Polarization Measurements**

- Glan-Taylor prism
- Software control of polarizer insertion and angle
- Polarization measurement angle setting:
  - 0, 90, 45, <u>0</u> and <u>90</u> deg., arbitrary angle settings
- Optional analyzer



# Optional Auto XYZ Stage

- Working range: 76 (X) x 52 (Y) x 20 (Z) mm
- Minimum XYZ increment: 1 μm
- Mapping measurements, line measurements, multi-point measurements
- Microscopic fixed wavelength mapping measurements

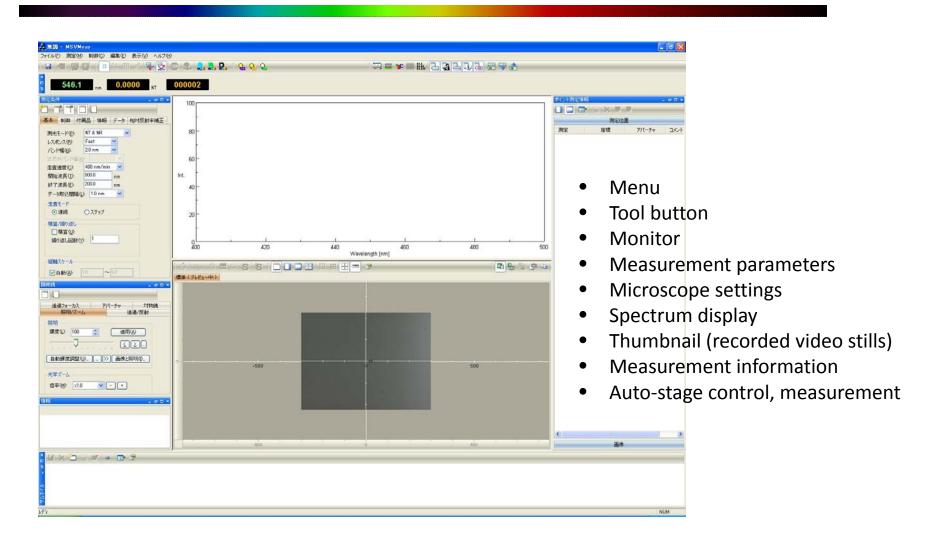


# **User-Friendly Spectra Manager II**

- Microscopic measurement, microscopic time course measurement
- Microscopic analysis, spectrum analysis, common analysis functions
- Expanded functions with optional auto-stage
  - Mapping measurement, line measurement, multi-points measurements, microscopic fixed wavelength mapping measurements

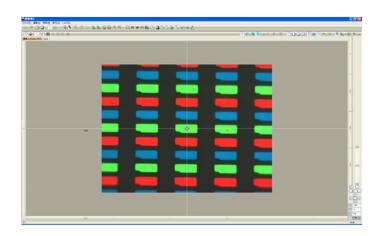


# Microscopic Measurement Program

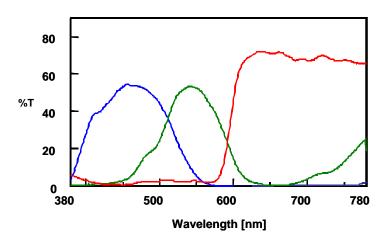




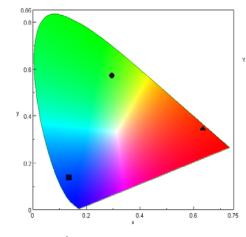
# Transmittance Measurement of LCD Panel



Observation display of color filter (75 x 30  $\mu$ m)



Transmittance spectra (10 μm aperture)



**Chromaticity Map** 





#### Optical elements

- Transmission characteristics of micro filters
- Reflection characteristics of micro dichroic mirrors

#### Semiconductors, electrical materials

- Band-gap measurement of micro parts
- Film thickness measurements

#### Functional materials

Optical constants of a crystal

#### Paintings

- Spectroscopic evaluation of a paint sample
- Spectroscopic determination of paintings